

Triacs

high noise immunity

BT139X series H

GENERAL DESCRIPTION

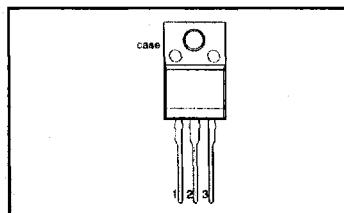
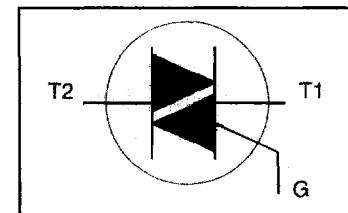
Glass passivated triacs in a full pack, plastic envelope, intended for use in applications requiring high noise immunity in addition to high, bidirectional blocking voltage capability and thermal cycling performance. Typical applications include motor control, industrial lighting, heating and static switching.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	MAX.	MAX.	UNIT
		BT139X-	500H	600H	
V_{DRM}	Repetitive peak off-state voltages	500	600	800	V
$I_{T(RMS)}$	RMS on-state current	16	16	16	A
I_{TSM}	Non-repetitive peak on-state current	140	140	140	A

PINNING - SOT186A

PIN	DESCRIPTION
1	main terminal 1
2	main terminal 2
3	gate
case	isolated

PIN CONFIGURATION**SYMBOL****LIMITING VALUES**

Limiting values in accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.			UNIT
V_{DRM}	Repetitive peak off-state voltages		-	-500	-600	-800	V
$I_{T(RMS)}$	RMS on-state current	full sine wave; $T_{hs} \leq 38^\circ\text{C}$	-	500 ¹	600 ¹	800	
I_{TSM}	Non-repetitive peak on-state current	full sine wave; $T_j = 25^\circ\text{C}$ prior to surge $t = 20\text{ ms}$ $t = 16.7\text{ ms}$ $t = 10\text{ ms}$	-	16			A
I^2t dI/dt	I^2t for fusing Repetitive rate of rise of on-state current after triggering	$I_M = 20\text{ A}; I_G = 0.2\text{ A};$ $dI_G/dt = 0.2\text{ A}/\mu\text{s}$	-	140	150	98	A ² s
I_{GM}	Peak gate current	T2+ G+	-	50			$\text{A}/\mu\text{s}$
V_{GM}	Peak gate voltage	T2+ G-	-	50			$\text{A}/\mu\text{s}$
P_{GM}	Peak gate power	T2- G-	-	50			$\text{A}/\mu\text{s}$
$P_{G(AV)}$	Average gate power	T2- G+	-	10			$\text{A}/\mu\text{s}$
T_{sig}	Storage temperature		-	2			A
T_j	Operating junction temperature	over any 20 ms period	-40	5	5	0.5	V
			-	150	125	150	W
			-			125	$^\circ\text{C}$

¹ Although not recommended, off-state voltages up to 800V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 15 A/ μs .

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ISOLATION LIMITING VALUE & CHARACTERISTIC $T_{hs} = 25^\circ\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V_{isol}	R.M.S. isolation voltage from all three terminals to external heatsink	$f = 50-60 \text{ Hz}$; sinusoidal waveform; $\text{R.H.} \leq 65\%$; clean and dustfree	-		2500	V
C_{isol}	Capacitance from T2 to external heatsink	$f = 1 \text{ MHz}$	-	10	-	pF

THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
R_{thj-hs}	Thermal resistance junction to heatsink	full or half cycle with heatsink compound	-	-	4.0	K/W
R_{thj-a}	Thermal resistance junction to ambient	without heatsink compound in free air	-	55	5.5	K/W

STATIC CHARACTERISTICS $T_j = 25^\circ\text{C}$ unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I_{GT}	Gate trigger current	$V_D = 12 \text{ V}$; $I_T = 0.1 \text{ A}$				
		$T_2+ \text{ G+}$	10	14	50	mA
		$T_2+ \text{ G-}$	10	17	50	mA
		$T_2- \text{ G+}$	10	18	50	mA
		$T_2- \text{ G-}$	10	40	100	mA
I_L	Latching current	$V_D = 12 \text{ V}$; $I_{GT} = 0.1 \text{ A}$				
		$T_2+ \text{ G+}$	-	10	60	mA
		$T_2+ \text{ G-}$	-	25	90	mA
		$T_2- \text{ G+}$	-	12	60	mA
		$T_2- \text{ G-}$	-	14	90	mA
I_H	Holding current	$V_D = 12 \text{ V}$; $I_{GT} = 0.1 \text{ A}$	-	8	60	mA
V_T	On-state voltage	$I_T = 20 \text{ A}$	-	1.2	1.6	V
V_{GT}	Gate trigger voltage	$V_D = 12 \text{ V}$; $I_T = 0.1 \text{ A}$	-	0.7	1.5	V
I_D	Off-state leakage current	$V_D = 400 \text{ V}$; $I_T = 0.1 \text{ A}$; $T_j = 125^\circ\text{C}$ $V_D = V_{DRM(max)}$; $T_j = 125^\circ\text{C}$	0.25	0.4	-	V
			-	0.1	0.5	mA

DYNAMIC CHARACTERISTICS $T_j = 25^\circ\text{C}$ unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
dV_D/dt	Critical rate of rise of off-state voltage	$V_{DM} = 67\% V_{DRM(max)}$; $T_j = 125^\circ\text{C}$; exponential waveform; gate open circuit	200	500	-	V/ μ s
dV_{com}/dt	Critical rate of change of commutating voltage	$V_{DM} = 400 \text{ V}$; $T_j = 95^\circ\text{C}$; $I_{T(RMS)} = 16 \text{ A}$; $dl_{com}/dt = 7.2 \text{ A/ms}$; gate open circuit	10	20	-	V/ μ s
t_{gt}	Gate controlled turn-on time	$I_{TM} = 20 \text{ A}$; $V_D = V_{DRM(max)}$; $I_G = 0.1 \text{ A}$; $dl_G/dt = 5 \text{ A/\mus}$	-	2	-	μ s

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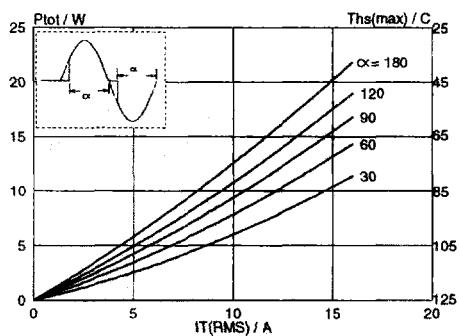


Fig.1. Maximum on-state dissipation, P_{tot} , versus rms on-state current, $I_{T(RMS)}$, where α = conduction angle.

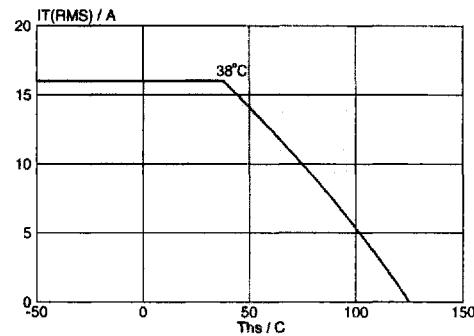


Fig.4. Maximum permissible rms current $I_{T(RMS)}$, versus heatsink temperature T_{hs} .

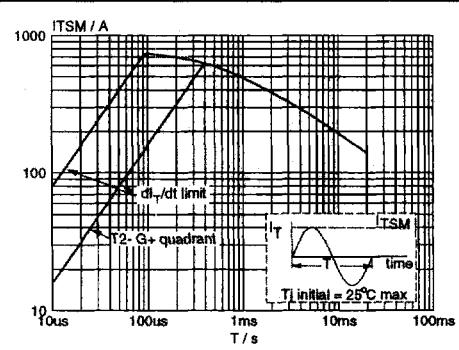


Fig.2. Maximum permissible non-repetitive peak on-state current I_{TSM} , versus pulse width t_p , for sinusoidal currents, $t_p \leq 20\text{ms}$.

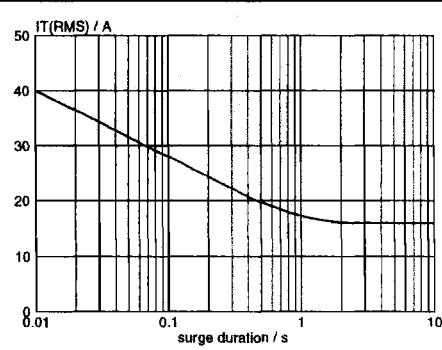


Fig.5. Maximum permissible repetitive rms on-state current $I_{T(RMS)}$, versus surge duration, for sinusoidal currents, $f = 50\text{ Hz}$; $T_{hs} \leq 38^\circ\text{C}$.

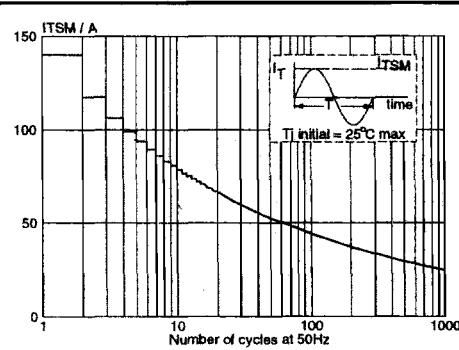


Fig.3. Maximum permissible non-repetitive peak on-state current I_{TSM} , versus number of cycles, for sinusoidal currents, $f = 50\text{ Hz}$.

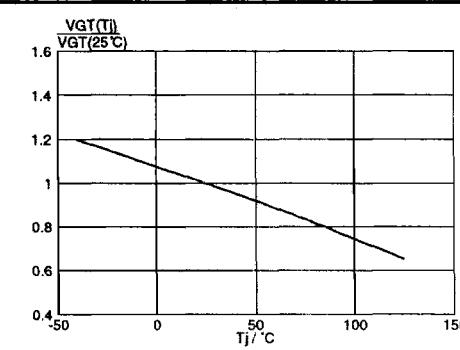


Fig.6. Normalised gate trigger voltage $V_{GT}(T_j)/V_{GT}(25^\circ\text{C})$, versus junction temperature T_j .

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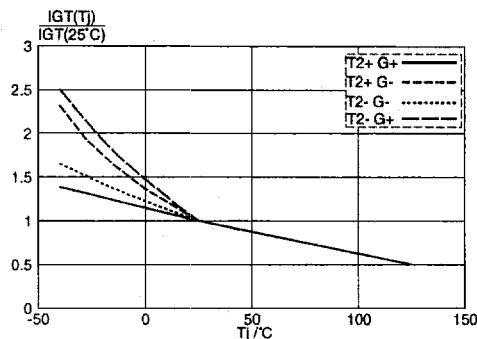


Fig.7. Normalised gate trigger current
 $I_{GT}(T_j)/I_{GT}(25^\circ C)$, versus junction temperature T_j .

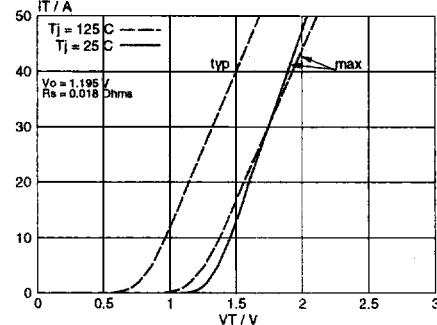


Fig.10. Typical and maximum on-state characteristic.

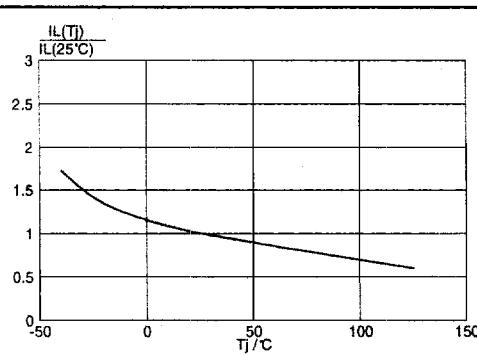


Fig.8. Normalised latching current $I_L(T_j)/I_L(25^\circ C)$, versus junction temperature T_j .

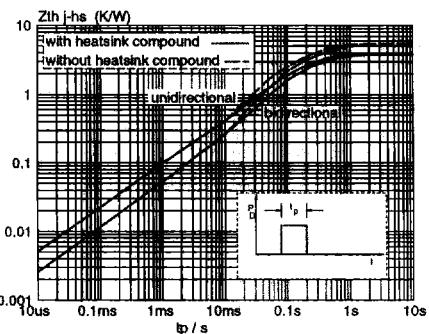


Fig.11. Transient thermal impedance $Z_{th(j-hs)}$, versus pulse width t_p .

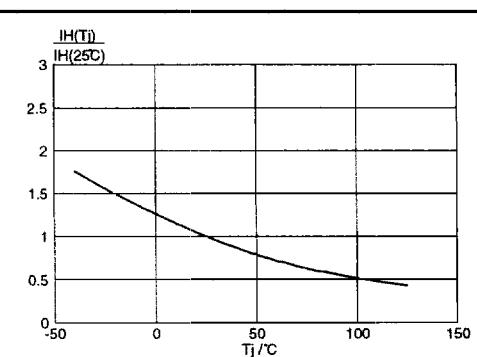


Fig.9. Normalised holding current $I_H(T_j)/I_H(25^\circ C)$, versus junction temperature T_j .

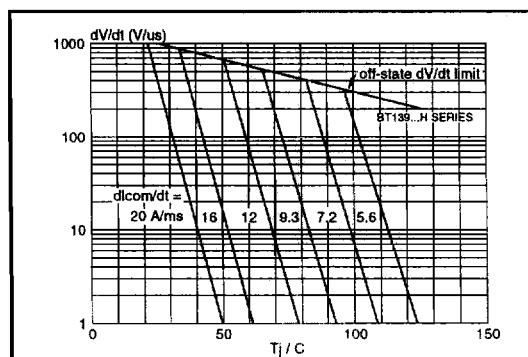


Fig.12. Typical commutation dV/dt versus junction temperature, parameter commutation dl/dt . The triac should commutate when the dV/dt is below the value on the appropriate curve for pre-commutation dl/dt .